

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/733,339	<b>Applicant(s)/Patent under Reexamination</b> TOBITA, ATSUHIRO
<b>Examiner</b> Y. J. Han	<b>Art Unit</b> 2838	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<i>See search report</i>		10/05	<i>gj</i>